

National Vocational & Technical Training Commission (NAVTTC)
(Screening Tests for Information Technology, Aesthetics, Health Care & Services, Banking And Finance, Construction with Electrical/Energy, Hospitality And Tourism, Languages, Manufacturing And Textile)

(Roll No Slip)

Roll No: 9207898

Name: Syed Saddam Hussain Shah

Father Name: Shahid Naseem Shah

CNIC: 35202-4636367-9

Paper Type: High Tech

Trade Applied: Information Technology

Test Date: Sunday 23rd February 2025

Reporting Time: 08:00 AM

AL KHAWARIZMI INSTITUTE OF COMPUTER SCIENCE UNIVERSITY OF ENGINEERING AND

Test Center: TECHNOLOGY LAHORE AL-KHAWARIZMI INSTITUTE OF COMPUTER SCIENCE (KICS), UNIVERSITY

OF ENGINEERING & TECHNOLOGY LAHORE (UET), GT ROAD LAHORE

NOTE: Candidates are provisionally allowed to appear in the test. Subject to verification of credentials and eligibility criteria.

Note (Warning):

- You are advised to bring this ROLL NO SLIP along with your original National ID Card or Passport (18 years age) or B Form and Matric Certificate (Less than 18 years age) containing your photograph (Mandatory).
 Candidate failing to produce ROLL NO SLIP and original CNIC would not be allowed to enter the examination hall.
- You are also required to bring clipboard and ball pen (black or blue) with you.
- Mobile Phone, Calculators or Any Other Electronic Device is Not Allowed in The Test Center Premises.
- Mobile collection facility will not be provided at test center.
- Please don't bring any of Gadget with you. Candidate may be searched for mobile phone / electronic device and if found it will be confiscated and paper will be cancelled.
- If your CNIC / B. Form is lost, bring Original NADRA token with any original document containing your photograph.
- No candidate will be allowed to enter the examination hall after 30 minutes of start of test.

اختباہ: ٹمیٹ سینٹری حدود میں موبائل فون لانا تختی ہے مع بائل اور الیکڑا کہ آلات کے لیم آپ کی جامع تناشی کی عبر Cancel کر دیا جائے گا

Current Date / Time: Saturday 22nd, February 2025, 05:05:52 AM

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